



PRODUCT DATA SHEET



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Datasheet

es Samples

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



General Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
30V	6 m Ω	80A

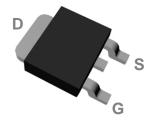
Features

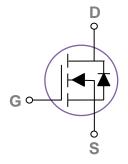
- 30V,80A, $RDS(ON) = 6m\Omega@VGS = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green Device Available

Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR

TO252 Pin Configuration





Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _G S	Gate-Source Voltage	±20	V
I_	Drain Current – Continuous (T _C =25°C)	80	А
lD	Drain Current – Continuous (T _C =100°C)	51	А
I _{DM}	Drain Current – Pulsed ¹	320	А
EAS	Single Pulse Avalanche Energy ²	88	mJ
IAS	Single Pulse Avalanche Current ²	42	А
D	Power Dissipation (Tc=25°C)	54	W
P_D	Power Dissipation – Derate above 25°C	0.43	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		62	°C/W
Rejc	Thermal Resistance Junction to Case		2.3	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Static State Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.04		V/°C
l	Drain Source Leekage Current	V _{DS} =30V , V _{GS} =0V , T _J =25°C			1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =125°C			10	uA
Igss	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA
D	0, 1, 5, 1, 0, 0, 5, 1, 1, 3	V _{GS} =10V , I _D =20A		4.8	6	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance ³	V _{GS} =4.5V , I _D =10A		6.5	9	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V V I- 250uA	1.2	1.6	2.5	V
△V _{GS(th)}	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =250uA		-4		mV/°C
gfs	Forward Transconductance	V _{DS} =10V , I _D =10A		18		S

Dynamic Characteristics

Qg	Total Gate Charge ^{3,4}		 11.1	
Q_{gs}	Gate-Source Charge ^{3,4}	V_{DS} =15V , V_{GS} =4.5V , I_{D} =20A	 1.85	 nC
Q_{gd}	Gate-Drain Charge ^{3, 4}		 6.8	
T _{d(on)}	Turn-On Delay Time ^{3, 4}		 7.5	
Tr	Rise Time ^{3, 4}	V_{DD} =15V , V_{GS} =10V , R_{G} =3.3 Ω	 14.5	 no
T _{d(off)}	Turn-Off Delay Time ^{3, 4}	I _D =15A	 35.2	 ns
T _f	Fall Time ^{3, 4}		 9.6	
Ciss	Input Capacitance		 1160	
Coss	Output Capacitance	V _{DS} =25V , V _{GS} =0V , F=1MHz	 200	 pF
C _{rss}	Reverse Transfer Capacitance		 180	
Rg	Gate resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	 2.5	 Ω

Guaranteed Avalanche Energy

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
EAS	Single Pulse Avalanche Energy	V _{DD} =25V, L=0.1mH, IAS=20A	20			mJ	

Drain-Source Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V V 0V Fares Command			80	Α
lsм	Pulsed Source Current ³	V _G =V _D =0V , Force Current			320	Α
V _{SD}	Diode Forward Voltage ³	V _{GS} =0V , I _S =1A , T _J =25°C			1	V

Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =42A., R_G =25 Ω ,Starting T_J =25 $^{\circ}$ C.
- 3. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 4. Essentially independent of operating temperature.

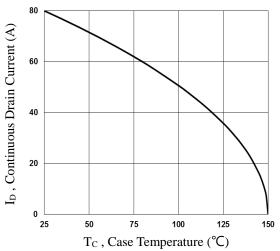


Fig.1 Continuous Drain Current vs. Tc

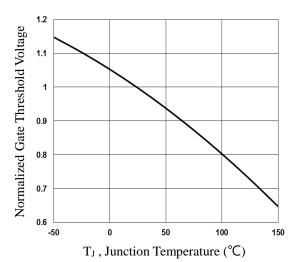


Fig.3 Normalized V_{th} vs. T_J

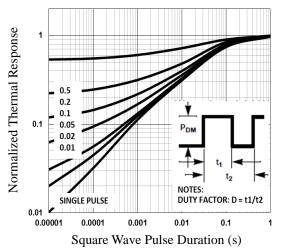


Fig.5 Normalized Transient Impedance

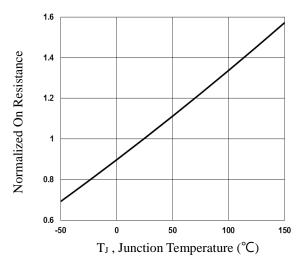


Fig.2 Normalized RDSON vs. T_J

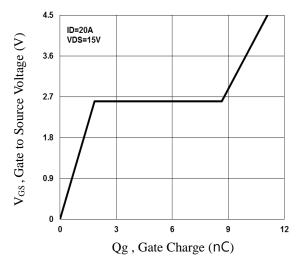


Fig.4 Gate Charge Waveform

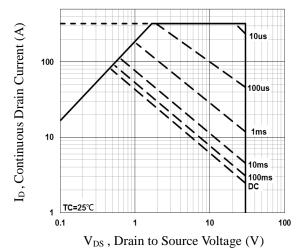


Fig.6 Maximum Safe Operation Area



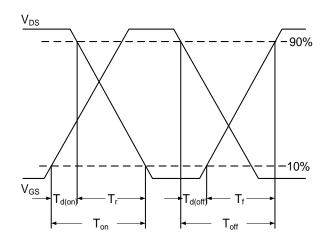


Fig.7 Switching Time Waveform

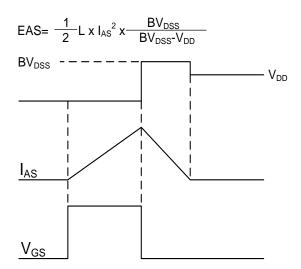
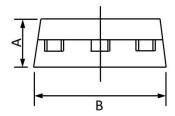
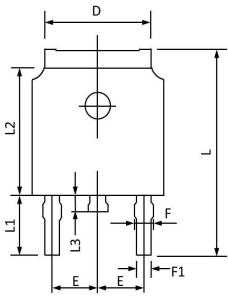


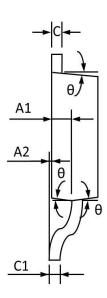
Fig.8 EAS Waveform



TO252 PACKAGE INFORMATION







Currele el	Dimensions In Millimeters		Dimensions In Inche	
Symbol	MAX	MIN	MAX	MIN
A	2.450	2.150	0.096	0.085
A1	1.200	0.910	0.047	0.036
A2	0.150	0.000	0.006	0.000
В	6.800	6.300	0.268	0.248
с	0.580	0.350	0.023	0.014
C1	0.550	0.380	0.022	0.015
D.	5.500	5.100	0.217	0.201
E	2.390	2.000	0.094	0.079
F	0.940	0.600	0.037	0.024
F1	0.860	0.500	0.034	0.020
	10.400	9.400	0.409	0.370
L1	3.000	2.400	0.118	0.094
<u>L2</u>	6.200	5.300	0.244	0.209
L3	1.200	0.600	0.047	0.024
θ	9°	3°	9°	3°



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